## Machine Learning Application on the Investigation of the Micro-Bunching Instability at Storage Rings

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## Micro-Bunching Instability

Motivation and Introduction

- operation of storage rings with short electron bunches increases coherent synchrotron radiation (CSR) power
- leads to micro-structure dynamics within the bunch
measurements
- indirect: resulting fluctuations in the emitted CSR power
- direct: electron distribution, challenging due to the small scale of the micro-structures
$\Rightarrow$ KIT storage ring KARA (KArlsruhe Reasearch Accelerator) has a dedicated short-bunch mode
$\Rightarrow$ synchronized sensor network (e.g. KAPTURE ${ }^{(1)}$ and KALYPSO ${ }^{(2)}$ ) enables studies of beam dynamics turn-by-turn
${ }^{(1)}$ Caselle, M. et al. JINST 12 C01040 (2017) $\quad{ }^{(2)}$ Rota, L., Caselle, M. et al. IBIC WEPG46 (2016)


## Micro-Bunching Instability

Occurrence of Micro-Structures within the Electron Bunch

- electro-optical near-field setup at KARA enables the measurement of longitudinal bunch profiles
- small micro-structures within the electron bunch can be observed



## Micro-Bunching Instability

Fluctuations of the emitted CSR Power

$\Rightarrow$ micro-structure dynamics lead to fluctuating CSR emission

## Micro-Bunching Instability

Beam Dynamics are changing with Bunch Current

$\Rightarrow$ CSR power spectrogram reveals distinct frequencies

## Simulation Code Inovesa

VFP Solver to study the Longitudinal Dynamics

- in-house developed at KIT, published as open source project: https://github.com/Inovesa/Inovesa


## Machine Learning

Analysis of the Longitudinal Bunch Profiles using $k$-means
Motivation:

- identify the dominant micro-structures and their correlation to the fluctuating CSR emission
- around 1.5 million bunch profiles in the data set corresponding to a simulated CSR power spectrogram
$\Rightarrow$ application of $k$-means to the bunch profiles within a specific bunch current

Investigation:

- Does the shape of these micro-structures follow a pattern or are they rather random fluctuations?
- Is it possible to characterize their nature by only a few different discrete states (clusters)?


## Machine Learning

## Unsupervised Learning: Clustering Method $k$-means


iter. \#1: update

initialization

iter. \#2: assignment

iter. \#1: assignment

iter. \#2: update


## Analysis of Micro-Structure Dynamics

## Different Bursting Regimes: Exemplary Bunch Currents



## Regular Bursting Regime

Cluster Centers, $I_{\text {reg }}=0.88 \mathrm{~mA}, k=2$ ( 10000 profiles)


## Regular Bursting Regime

Referenced Cluster Centers, $I_{\text {reg }}=0.88 \mathrm{~mA}, k=2$


## Regular Bursting Regime

Correlation to CSR Power, $I_{\text {reg }}=0.88 \mathrm{~mA}, k=2$


## Regular Bursting Regime

Correlation to CSR Power, $I_{\text {reg }}=0.88 \mathrm{~mA}, k=2$


## Regular Bursting Regime

Longitudinal Phase Space Density, $I_{\text {reg }}=0.88 \mathrm{~mA}, k=2$


## Sawtooth Bursting Regime

Cluster Centers, $I_{\text {saw }}=1.15 \mathrm{~mA}, k=4$


## Sawtooth Bursting Regime

Referenced Cluster Centers, $I_{\text {saw }}=1.15 \mathrm{~mA}, k=4$


## Sawtooth Bursting Regime

Correlation to CSR Power, $I_{\text {reg }}=1.15 \mathrm{~mA}, k=4$


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## Micro-Structure Characteristics

Modulation Frequencies across different Bunch Currents


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## Micro-Structure Characteristics

Modulation Amplitudes across different Bunch Currents


## Summary

What was gained by using Machine Learning?

- efficient tool for data exploration and knowledge extraction
- distinct micro-structures could be identified
- yields the possibility to correlate the results to the fluctuations of the CSR power
- new insights gained, e.g. number of structures is a constant across different bunch currents
$\Rightarrow$ still useful for further studies of the micro-structure characteristics as it yields very condensed information about the dynamics


## Outlook

Further Studies using the Application of $k$-means

$\Rightarrow$ number of micro-structures changes with vacuum gap

## Outlook

Further Studies using the Application of $k$-means


## Thank you for your attention!

## Backup

## Backup

## Simulation Parameters

| Physical parameter | Value |
| :--- | :--- |
| RF voltage $U_{0}$ | 1 MV |
| revolution frequency $f_{\text {rev }}$ | 9 MHz |
| synchrotron frequency $f_{\mathrm{s}}$ | 30 kHz |
| damping time $\tau_{\mathrm{d}}$ | 5 ms |
| harmonic number $h$ | 50 |
| parallel plates distance $g$ | 3.2 cm |
| initial electron distribution $\varphi\left(z, E, t_{0}\right)$ | 2 -dim. Gaussian |
| simulation time $t$ | $250 T_{\mathrm{s}}$ |
| bunch current $l_{\text {bunch }}$ | 0.5 mA to 2.0 mA |
|  |  |
| Control parameter | Value |
| grid size $n_{\text {grid }}$ | 256 |
| time steps $n_{\text {steps }}$ | 10000 |

## Backup

Simulation and Measurement: Longitudinal Bunch Profiles


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Simulation and Measurement: Longitudinal Bunch Profiles


## Backup

Simulation and Measurement: CSR Power Spectrogram

$\Rightarrow$ simulation and measurement show qualitative agreement

